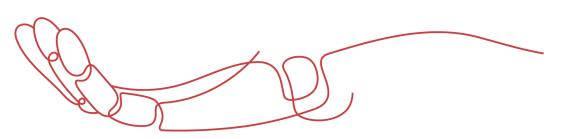




PRODUCT DATA SHEET



To learn more about JGSEMI, please visit our website at







Datasheet Resource

Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.



General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BVDSS	RDSON	ID
100V	130m $Ω$	10A

Features

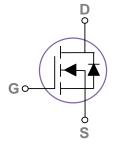
- 100V,10A, RDS(ON)=130mΩ@VGS=10V
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

Applications

- Networking
- Load Switch
- LED applications

PPAK3X3





Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	100	V
V _G S	Gate-Source Voltage	±20	V
ı	Drain Current – Continuous (T _C =25°C)	10	А
ID	Drain Current – Continuous (Tc=100°C)	6.3	А
I _{DM}	Drain Current – Pulsed ¹	40	А
EAS	Single Pulse Avalanche Energy ²	6	mJ
IAS	Single Pulse Avalanche Current ²	11	А
D-	Power Dissipation (Tc=25°C)	29.8	W
P _D	Power Dissipation – Derate above 25°C	0.24	W/°C
T _{STG}	Storage Temperature Range	-50 to 150	℃
TJ	Operating Junction Temperature Range	-50 to 150	℃

Thermal Characteristics

Symbol	mbol Parameter		Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient		62	°C/W
Rejc	Thermal Resistance Junction to Case		4.2	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions		Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	100			٧
△BV _{DSS} /△T _J	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.09		V/°C
IDSS	Drain Source Leakage Current	V _{DS} =100V , V _{GS} =0V , T _J =25°C			1	uA
	Drain-Source Leakage Current	V _{DS} =80V , V _{GS} =0V , T _J =125°C		1	10	uA
I _{GSS}	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA

On Characteristics

R _{DS(ON)} Static Drain-Source On-Resistant	Static Prain Source On Registence	V _{GS} =10V , I _D =10A		100	130	mΩ
	Static Dialii-Source Off-Resistance	V _{GS} =4.5V , I _D =8A		105	140	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V V 1 250		1.6	2.5	V
$\triangle V_{GS(th)}$	$\triangle V_{GS(th)}$ $V_{GS(th)}$ $V_{GS(th)}$ Temperature Coefficient			-5		mV/°C
gfs	Forward Transconductance	V _{DS} =10V , I _D =10A		8.7		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{3,4}			20	40	
Q_{gs}	Gate-Source Charge ^{3,4}	ve Charge ^{3,4} V _{DS} =50V , V _{GS} =10V , I _D =2A		3.2	6	nC
Q_{gd}	Gate-Drain Charge ^{3,4}			3.6	7	
$T_{d(on)}$	Turn-On Delay Time ^{3,4}			18	36	
Tr	Rise Time ^{3,4}	V_{DD} =50 V , V_{GS} =10 V , R_{G} =3.3 Ω		4	8	no
T _{d(off)}	Turn-Off Delay Time ^{3,4}	I _D =1A		40	80	ns
T _f	Fall Time ^{3,4}			3	6	
Ciss	Input Capacitance			1400	2800	
Coss	Output Capacitance V _{DS} =25V , V _{GS} =0V , F=1MHz			60	120	pF
Crss	Reverse Transfer Capacitance			35	70	
Rg	Gate resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz		2	4	Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	V _G =V _D =0V , Force Current			10	А
I _{SM}	Pulsed Source Current	VG=VD=UV, FOICE Current			20	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25°C			1	V
t _{rr}	Reverse Recovery Time ³	I- 4A - 41/44 400A/ T 05°C		38		ns
Qrr	Reverse Recovery Charge ³	Is=1A , dI/dt=100A/μs T _J =25°C		27		nC

Note:

- Repetitive Rating: Pulsed width limited by maximum junction temperature.
 V_{DD}=25V,V_{GS}=10V,L=0.1mH,I_{AS}=11A.,R_G=25Ω,Starting T_J=25°C.
- 3. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 4. Essentially independent of operating temperature.



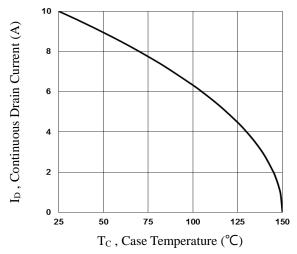


Fig.1 Continuous Drain Current vs. Tc

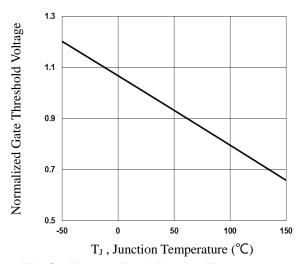


Fig.3 Normalized V_{th} vs. T_J

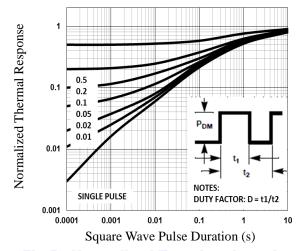


Fig.5 Normalized Transient Impedance

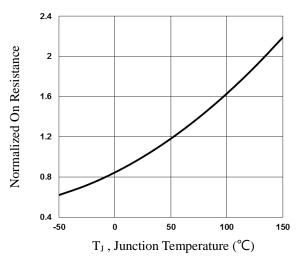


Fig.2 Normalized RDSON vs. TJ

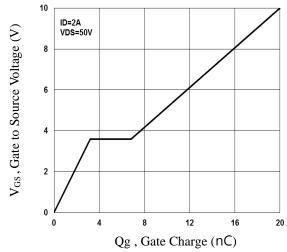


Fig.4 Gate Charge Waveform

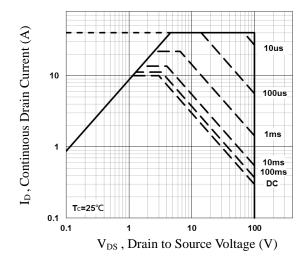
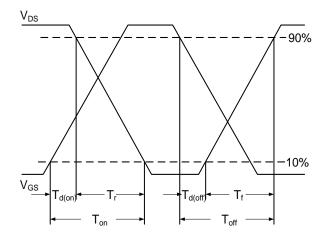


Fig.6 Maximum Safe Operation Area



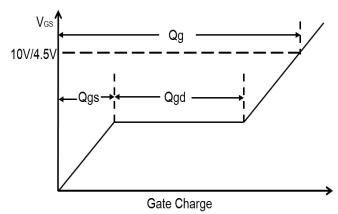
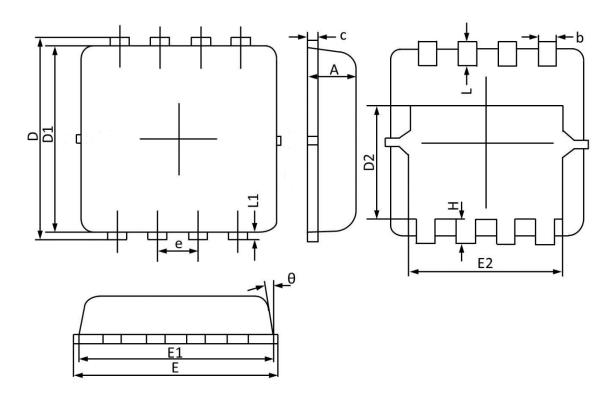


Fig.7 Switching Time Waveform

Fig.8 Gate Charge Waveform



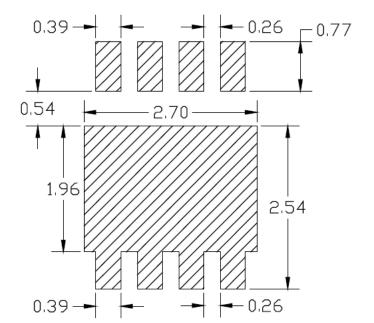
PPAK3x3 PACKAGE INFORMATION



Symbol	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	MAX	MIN	MAX	MIN
Α	0.900	0.700	0.035	0.028
b	0.350	0.250	0.014	0.010
С	0.250	0.100	0.010	0.004
D	3.500	3.050	0.138	0.120
D1	3.200	2.900	0.126	0.114
D2	1.950	1.350	0.077	0.053
E	3.400	3.000	0.134	0.118
E1	3.300	2.900	0.130	0.114
E2	2.600	2.350	0.102	0.093
е	0.65	BSC	0.02	6BSC
Н	0.750	0.300	0.030	0.012
L	0.600	0.300	0.024	0.012
L1	0.200	0.060	0.008	0.002
θ	14°	6°	14°	6°



PPAK3X3 RECOMMENDED LAND PATTERN



unit: mm



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